

**WEST****Freeform Search**

**Database:** US Patents Full-Text Database  
US Pre-Grant Publication Full-Text Database  
JPO Abstracts Database  
EPO Abstracts Database  
Derwent World Patents Index  
IBM Technical Disclosure Bulletins

**Term:** 18 and 14

**Display:** 25 **Documents in Display Format:** CIT **Starting with Number** 1

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USPT,PGPB	18 and 14	5	<u>L9</u>
USPT,PGPB	11 and ((216/59 or 216/79 or 216/80 or 438/14 or 438/723).ccls.)	569	<u>L8</u>
USPT,PGPB	14 same (fluoro carbon or "C.sub.4 F.sub.8")	4	<u>L7</u>
USPT,PGPB	12 and (ratio same (carbon near3 fluorine))	13	<u>L6</u>
USPT,PGPB	12 and 14	1	<u>L5</u>
USPT,PGPB	13 same (control\$3 or detect\$3)	2355	<u>L4</u>
USPT,PGPB	(residence time) same gas	10996	<u>L3</u>
USPT,PGPB	11 same (fluoro carbon or "C.sub.4 F.sub.8")	154	<u>L2</u>
USPT,PGPB	(etch\$3 or coat\$3 or deposit\$3) same (silicon near2 oxide or "Si O.sub.2")	28106	<u>L1</u>